Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/663,811	HACHERL ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

SEARCHED					
Class	Subclass	Date	Examiner		
726	2-4, 27-30	9/28/2005	S.C.		
709	229	9/28/2005	S.C.		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST .	9/28/2005	S.C.
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